Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/603,937	MIYAGAWA, ICHIROU
Examiner	Art Unit

2861

Hai C. Pham

	SEARCHED			
Class	Subclass	Date	Examiner	
347	241, 256	5/23/2005	НР	
359	196	5/23/2005	НР	
369	44.23	5/23/2005	HP	
	•			
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
· <u>-</u>				

(EARCH STRATEGY	'
	DATE	EXMR
EAST	5/23/2005	НР
•		